INFORMATION DISCLOSURE CITATION IN AN APPLICATION					ATTY. DOCKET NO. 67161-127	SERIAL NO.			
					APPLICANT Yoshiharu ONO				
(PTO-1449)					FILING DATE November 6, 2003				
U.S. PATENT					NT DOCUMENTS	DOCUMENTS			
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (# known)		Publication Date MM-DD-YYYY			Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US						ı	
		US D9			······································		ļ	<u> </u>	
	 	US			- 		-		
	 	US							
		US						-	
	<u> </u>	US							
		US							
	<u> </u>	US							
		US							
		US							
		US							
		US	and the state of t						
EXAMINER'S		É	market and the second	Publication Date	Name of Patentee or Applicant	Last. La Last.	Line 1	35	
INITIALS			untry Codes -Number 4 -Kind	MM-DD-YYYY	of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation		
			JP 2001-358218 A	12/26/2001	MITSUBISHI DENKI		Yes	No	
k-11C			JP 2001~356216 A	12/26/2001	MITSUBISHI DENKI KABUSHIKI KAISHA & RYODEN SEMICONDUCTOR SYSTEM ENGINEERING CORPORATION		JAPAN (w/ English Commentary on the Reference)		
						<u> </u>	<u> </u>		
							 		
			OTHER	ART (Including Auth	ior, Title, Date, Pertinent Pages, Etc)/ 5°	<u> </u>		
EXAMINER'S INITIALS	EXAMINER'S Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal.								
EXAMINER S					7-19	DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.